

FDE Interpretation # 201805

Status: *Active* *Inactive*

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Type of Document: *Technical Decision* *Technical Recommendation*

Approved by: *FDE iTC Interpretations Team* *FDE iTC*

Affected Document(s): FDE AA SD V2.0

Affected Section(s): FCS_CKM.4(a)

Superseded Interpretation(s):

Issue:

in the SD for cpp_fde_aa v2 FCS_CKM.4(a) Cryptographic Key Destruction (Power Management) is this:
"Test: The test activities performed for this SFR are identical to those performed for FCS_CKM.4(a)."

But this is fcs_ckm.4(a). The reference is circular, with NO tests defined in the SD for fcs_ckm.4(a)

ANd for fcs_ckm_ext.4(a) Destruction timing: "There are no test evaluation activities for this SFR."

FCS_CKM_ext.4(b) "There are no test evaluation activities for this SFR."

FCS_CKM_ext.4(d) has tests for 3rd party storage.

I would think the text should be changed to link it to a test or changed to "there are no test evaluation activities for this SFR" which would bring it in line with the FDE_EE.

Resolution:

The FIT acknowledges the issue described in the 'Issue' section above. The Test section of FCS_CKM.4(a) Cryptographic Key Destruction (Power Management) shall therefore be modified as follows:

Test

There are no test evaluation activities for this SFR.

Rationale:

This resolves the circular reference and aligns with the FDE EE SD.

Further Action:

None.

Action by FDE iTC:

None.